UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/586,305	07/14/2006	Kousuke Tanaka	1204.46401X00	2516	
20457 7590 06/29/2009 ANTONELLI, TERRY, STOUT & KRAUS, LLP			EXAMINER		
	SEVENTEENTH STRI	CAMPBELL, SHAUN M			
ARLINGTON, VA 22209-3873			ART UNIT	PAPER NUMBER	
			2829		
		MAIL DATE	DELIVERY MODE		
			06/29/2009	PAPER	

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Office Action Communication			Application No.		Applicant(s)				
			10/586,305		TANAKA ET AL.				
Office Action Summary			Examiner		Art Unit				
		:	SHAUN CAM	PBELL	2829				
Period fo	The MAILING DATE of this commun or Reply	ication appea	ars on the co	ver sheet with the c	correspondence ac	ddress			
WHIC - Exter after - If NC - Failu Any r	ORTENED STATUTORY PERIOD F CHEVER IS LONGER, FROM THE M Isions of time may be available under the provisions SIX (6) MONTHS from the mailing date of this comn period for reply is specified above, the maximum state to reply within the set or extended period for reply eply received by the Office later than three months and ad patent term adjustment. See 37 CFR 1.704(b).	IAILING DAT of 37 CFR 1.136 nunication. atutory period will will, by statute, ca	TE OF THIS  (a). In no event,  apply and will exause the applicate	COMMUNICATION however, may a reply be tin pire SIX (6) MONTHS from to become ABANDONE	N. nely filed the mailing date of this of D (35 U.S.C. § 133).				
Status									
1)	Responsive to communication(s) file	ed on <i>20 Apr</i>	il 2009						
•	•	2b)⊠ This a		-final					
3)		<i>,</i> —			secution as to the	e merits is			
٠/١	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.								
	·	oo undor Ex	parto Quay	0, 1000 0.5. 11, 10	00 0.0. 210.				
Dispositi	on of Claims								
4)🛛	Claim(s) 18,20 and 22-34 is/are pen	iding in the a	application.						
	4a) Of the above claim(s) is/are withdrawn from consideration.								
5)	Claim(s) is/are allowed.								
6)🖂	Claim(s) 18, 20 and 22-34 is/are reje	ected.							
·	Claim(s) is/are objected to.								
•	Claim(s) are subject to restrict	ction and/or e	election requ	uirement.					
	on Papers		·						
-	The specification is objected to by th								
10)	10)☐ The drawing(s) filed on is/are: a)☐ accepted or b)☐ objected to by the Examiner.								
	Applicant may not request that any obje		,	-	. ,				
	Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).								
11)	11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.								
Priority ι	ınder 35 U.S.C. § 119								
<ul> <li>12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some * c) None of:</li> <li>1. Certified copies of the priority documents have been received.</li> <li>2. Certified copies of the priority documents have been received in Application No</li> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>									
2)  Notic 3) Inform	e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (F nation Disclosure Statement(s) (PTO/SB/08) r No(s)/Mail Date <u>4/20/2009</u> .	PTO-948)	4) 5) 6)	<b>二</b>	ate				

Application/Control Number: 10/586,305 Page 2

Art Unit: 2829

#### **DETAILED ACTION**

1. RCE, received 4/20/2009, has been entered into the record.

2. Claims 18, 20 and 22-34 are presented for examination. Claims 1-17, 19 and 21 are canceled; claims 18, 20 and 22-24 are currently amended; and claims 25-34 are previously presented.

# Specification

3. The objections to the abstract are withdrawn in view of the amendments to the abstract received 4/20/2009.

## Claim Rejections - 35 USC § 103

- 4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 5. This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to

consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

- 6. Claims 18, 20, 22-26, 29, 30, and 34 are rejected under 35 U.S.C. 103(a) as being unpatentable over Usami et al. (US Patent No. 7,036,741 B2, hereafter referred to as Usami) in view of Yamakawa (US Patent No. 6,479,777 B2); and further in view of Summers (US Pub. No. 2003/0211652 A1).
- 7. As to claims 18-20, 22-24, 30 and 34, Usami discloses a manufacturing method for an electronic device that has IC elements (fig 2A, IC chip 16), each IC element having electrodes formed respectively on the respective surfaces of a pair of opposed sides thereof (fig 2A, electrodes 13 and 17), and a first circuit layer (fig 2B, 1<sup>st</sup> metal conductor 14 on upper substrate 12) and a second circuit layer (fig 2B, 2<sup>nd</sup> metal conductor 18 on lower substrate 19), comprising:

a step of forming a slit (fig 3, slit 22a and col. 11, lines 29-35) in the first circuit layer or the second circuit layer;

a step of forming a first connecting part for electrically connecting the electrode of one side of the IC elements and the first circuit layer, on the one side (fig 2B, electrode 13), a second connecting part for electrically connecting the electrode of the other side of the IC elements and the second circuit layer (fig 2B, electrode 17), and a third connecting part for electrically connecting the first and second circuit layers so that the

second connecting part and the third connecting part are connected spanning the slit (fig 2D, conductor-connection portion 20); and

a step of positionally aligning the connection surfaces of the IC elements and either one of the circuit layers (fig 15A, upper substrate 12h is aligned with lower substrate 19h using sprocket holes 141 and the chip is sandwiched between, col. 18, lines 33-42).

Usami does not explicitly disclose continuously supplying the IC elements individually into an IC elements transport mechanism [claim 18].

Nonetheless, Yamakawa discloses continuously supplying the IC elements individually into an IC elements transport mechanism (fig 1 and col. 5, lines 1-8); wherein the step of continuously supplying the IC elements comprises:

a step of individually holding an IC element (fig 2, electronic parts 2) in an IC element holding part (slots 2) of an IC elements transport mechanism (table 1) having not less than one IC element holding part (slots 2) which is formed as a notch shape (fig 2, slots 2); and

a step of delivering the IC element thus held by running the IC element holding part of the transport mechanism (col. 4, lines 29-67)[claim 18].

wherein the IC elements transport mechanism is a disc shaped IC elements transport mechanism (fig 2, disk-shaped conveying table 1) having not less than one IC element holding part [claim 20];

a step of aligning the IC elements by action of an IC elements alignment/supply mechanism (fig 1, feed device 15 and linear track 15a) to facilitate individually holding

Art Unit: 2829

the IC element in the IC element holding part of the IC elements transport mechanism having not less than one IC element holding part [claim 22]; and

a step of aligning the IC elements by action of an IC elements alignment/supply mechanism which is a line feeder (fig 1, feed device 15 and linear track 15a) to facilitate individually holding the IC element in the IC element holding part of the IC elements transport mechanism having not less than one IC element holding part [claim 23].

Yamakawa does not explicitly disclose a step of aligning the IC elements by action of an IC elements alignment/supply mechanism which is a high frequency alignment feeder to facilitate individually holding an IC element in an IC element holding part of an IC elements transport mechanism having not less than one IC element holding part [claim 24]. However, Yamakawa does disclose a step of aligning the IC elements by action of an IC elements alignment/supply mechanism (fig 1, feed device 15/15a and table 1) to facilitate individually holding an IC element in an IC element holding part of an IC elements transport mechanism having not less than one IC element holding part (fig 2, slots 2). Therefore Yamakawa discloses the claimed invention except for the alignment feeder runs at a high frequency. It would have been obvious to one having ordinary skill in the art at the time the invention was made to use the feeder and table of Yamakawa at a high frequency, since it has been held that where the general conditions of a claim are disclosed in the prior art, discovering the optimum or workable ranges involves only routine skill in the art. In re Aller, 105 USPQ 233.

Application/Control Number: 10/586,305

Art Unit: 2829

It would have been obvious to one of ordinary skill in the art at the time the invention was made to use the electronic parts conveying apparatus, as taught by Yamakawa, in order to continuously supply the IC elements into the sandwich as taught by fig 15A/B and col. 18, lines 33-42 of Usami because testing and sorting the IC elements before completing subsequent manufacturing steps will save the manufacturer the trouble of making chips that do not function properly.

Page 6

Usami in view of Yamakawa does not explicitly disclose a step of securing the IC element held by the IC element holding part at any of the circuit layers with a temporary securing pin.

Nonetheless, Summer discloses a step of securing an IC element held by an IC element holding part at any of the circuit layers with a temporary securing pin ([0034] lines 1-20).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to use the die delivery apparatus as taught by Summer in order to transfer the devices from the electronics parts conveying apparatus as taught by Yamakawa in view of Usami since it is taught in Summer that the use of a mechanical gripper or collate, as well as a magnetic head, and a vacuum are all known means for holding a die therefore one of skill in the art would have been able to choose which of these known means would be the best for a particular situation.

8. As to claim 25, Usami in view of Yamakawa and Summer discloses the manufacturing method for an electronic device according to claim 18 (paragraphs

Page 7

above).

Usami further discloses wherein the electrical connection of an electrode of the IC elements and at least one of the first and the second circuit layers is made via an anisotropic conductive adhesive layer (col. 10, lines 53-57).

9. As to claim 26, Usami in view of Yamakawa and Summer discloses the manufacturing method for an electronic device according to claim 18 (paragraphs above).

Usami further discloses further comprising: a step of connecting at once, the electrodes of the IC elements and at least one layer from among the first or the second circuit layers, wherein the step of connecting is after the step of positionally aligning the connection surfaces (col. 18, lines 33-42; where it would have been obvious to one of ordinary skill in the art that the sprocket holes are used for alignment).

10. As to claim 29, Usami in view of Yamakawa and Summer discloses the manufacturing method for an electronic device according to claim 26 (paragraphs above).

Usami further discloses further comprising: a step of cutting a continuum of a plurality of the IC elements into individual pieces (fig 21E, chip-separation portions 246 and Col. 22, lines 49-52).

Page 8

Art Unit: 2829

However, Usami does not explicitly disclose wherein the step of cutting is after the step of connecting, at once, a plurality of the IC elements with at least one from among the first and the second circuit layers.

Nonetheless, Usami does disclose the step of cutting is after the step of connecting, at once, a plurality of the IC elements with at least one form among the first and the second circuit layers (col. 18, lines 33-42).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to cut the devices from the tape into individual devices because these devices are usually made to be used individually and the reason for rolling the devices into a tape reel is for the advantage of easy handling of the wireless identification semiconductor devices (col. 18, lines 43-47), therefore it would be obvious to cut the devices as disclosed in fig 21E into individual devices be being used.

- 11. As to claim 30, Usami further discloses wherein a conductive layer (fig 2B, 1<sup>st</sup> metal conductor 14) is formed on the surface of at least one from among the first and the second circuit layers (fig 2B, upper substrate 12).
- 12. As to claim 34, Usami in view of Yamakawa and Summer discloses the manufacturing method for an electronic device according to claim 18 (paragraphs above).

Usami further discloses wherein electrical connections of electrodes of the IC elements and the first and second circuit layers are made via first and second anisotropic conductive adhesive layers, respectively (col. 10, lines 53-57).

Usami in view of Yamakawa does not explicitly disclose a total thickness of the first and second anisotropic conductive adhesive layers is not less than half the thickness of the IC elements.

However, It would have been obvious to one having ordinary skill in the art at the time the invention was made to make the device with a thickness not less than half the thickness of the IC elements, since it was held that where the general conditions of a claim are disclosed in the prior art, discovering the optimum or workable ranges involves only routine skill in the art. *In re Aller*, 105 USPQ 233.

- 13. Claims 27-28 and 31 are rejected under 35 U.S.C. 103(a) as being unpatentable over Usami in view of Yamakawa and Summer, and further in view of Moskowitz et al. (US Patent No. 5,528,222) hereafter referred to as Moskowitz.
- 14. As to claims 27 and 28, Usami in view of Yamakawa and Summer discloses the manufacturing method for an electronic device according to claim 26 (paragraphs above).

Usami in view of Yamakawa and Summer does not explicitly disclose wherein the method in that the electrodes of the IC elements and at least one layer from among

the first and the second circuit layers are connected at once is realized by thermal compression [claim 27]; or

wherein the gaps between the first and second circuits layers are sealed by the thermal compression [claim 28]. However, Usami does disclose using a pin to seal the gaps between the first and second circuits layers (fig 2C, press pin 21).

Nonetheless, Moskowitz discloses using thermal compression bonding in order to electrically connect circuits to a chip (col. 4, lines 13-16)[claims 27 and 28].

It would have been obvious to one of ordinary skill in the art at the time the invention was made to use thermal compression to connect the electrodes to the other circuit layers, since it was known in the art that thermal compression can be used to connect electrodes to other circuit layers.

- 15. As to claim 31, Usami further discloses wherein the first and second circuit layers include aluminum (col. 5, lines 30-32).
- 16. Claims 32 and 33 are rejected under 35 U.S.C. 103(a) as being unpatentable over Usami in view of Yamakawa and Summer and Moskowitz as applied to claim 28, and further in view of Green et al. (US Pub No. 2003/0136503 A1) hereafter referred to as Green.

Application/Control Number: 10/586,305 Page 11

Art Unit: 2829

17. As to claims 32 and 33, Usami in view of Yamakawa and Summer and Moskowitz disclose the manufacturing method for an electronic device according to claim 28 (paragraphs above).

Usami in view of Yamakawa and Summer and Moskowitz does not explicitly disclose wherein at least one from among the first and second circuit layers is supported on a base substrate comprised of an organic resin, and that this organic resin be selected from the group consisting of polyvinyl chloride (PVC), acrylonitrile butadiene styrene (ABS), polyethylene terephthalate (PET), polyethylene terephthalate glycol (PETG), polyethylene naphthalate (PEN), polycarbonate resin (PC), biaxial polyester (O-PET), and polyimide resin [claim 32]; or

wherein either one of the first or the second circuit layer is supported on a base substrate comprised of paper [claim 33].

Nonetheless, Green discloses a base substrate for a RFID webstock containing an semiconductor chips made out of these materials ([0138] lines 1-13)[claim 32] and wherein the substrate may comprise paper ([0036] lines 7-9).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to use the conventional features of using organic resin or paper as the substrate of Usami in view of Yamakawa and Summer and Moskowitz as taught by Green in order for the devices to be easily cut and also have dimensional and thermal stability.

## Response to Arguments

18. Applicant's arguments with respect to claims 18, 20 and 22-34 have been considered but are moot in view of the new ground(s) of rejection.

#### Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to SHAUN CAMPBELL whose telephone number is (571)270-3830. The examiner can normally be reached on Monday Through Friday 8:00AM-5:30PM EST.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nguyen Ha can be reached on (571) 272-1678. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/Shaun Campbell/

Application/Control Number: 10/586,305 Page 13

Art Unit: 2829

Examiner, Art Unit 2829 6/23/09

/Ha T. Nguyen/ Supervisory Patent Examiner, Art Unit 2829